

<b>Notice of References Cited</b>	Application/Control No. 10/587,167		Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Patricia T. Nguyen		Art Unit 2817	Page 1 of 1

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*	C	US-7,098,737 B2	08-2006	Fujimoto et al.	330/283
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